



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Chen, Fang-Zhong, et al.

) Art Unit
) 2829

For: METHODS, SYSTEMS, AND DEVICES FOR
BURN-IN TESTING OF OPTOELECTRONIC
DEVICES

Customer No.: 22913

Examiner: Jimmy Nguyen

Mail Stop AMENDMENT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

In response to the Office action mailed April 15, 2005 (the "Office Action"), please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks/Arguments begin on page 9 of this paper.